



ECHOGRAPH Probes

Sensors and Accessories for Ultrasonic Testing

KARL DEUTSCH

KARL DEUTSCH Prüf- und Messgeräetebau, Wuppertal Company Portrait

The privately owned company KARL DEUTSCH founded in 1949 develops and produces instruments for non-destructive material testing. Portable instruments, stationary testing systems, sensors and crack detection liquids are produced by 130 motivated employees in two works in Wuppertal. Additional 20 employees in international offices and a worldwide network of dealers support the export business which accounts for more than 50% of the turnover.

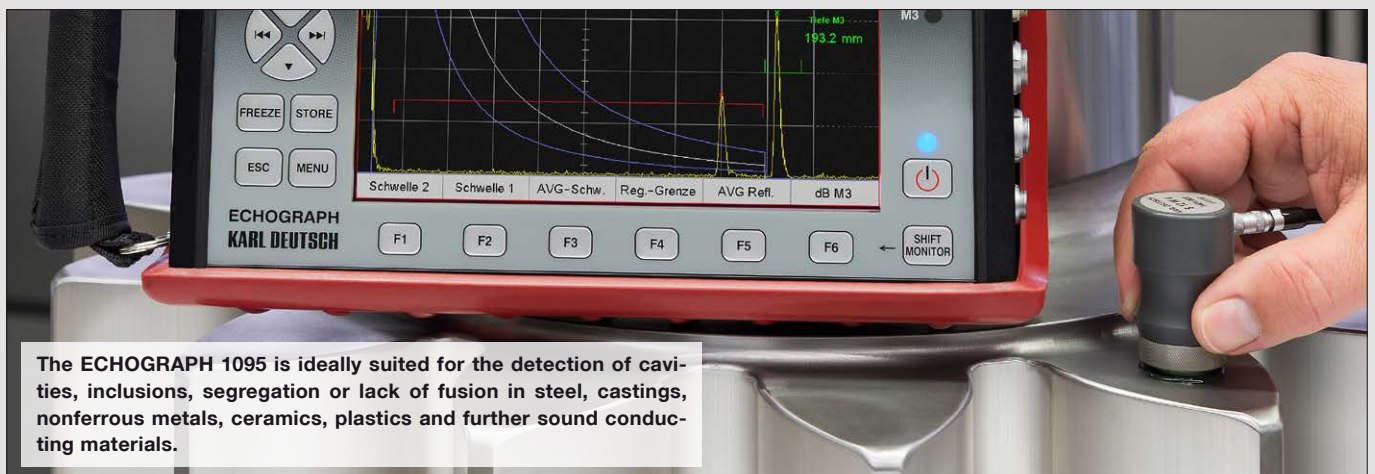
Our customers are metal producing and processing industries, e.g. steel works, automotive companies and bearing manufacturers. Typical test tasks are ultrasonic weld testing, detection of shrink holes in castings, crack detection in forgings with magnetic particles and dye penetrants, safety components for railway and aerospace as well as wall and coating thickness measurement.

Characterized by continuous innovation and product reliability, the trade marks ECHOGRAPH, ECHOMETER, DEUTROFLUX, LEPTOSKOP, FLUXA, KD-Check and RMG are well-recognized.



The staff of KARL DEUTSCH in front of a large testing system. Overall, an assembly area of 1800 m² and two overhead cranes are available in the testing systems workshop.

We have application experience, theoretical knowledge and manufacturing know-how for more than six decades. These benefits combined with standard compliant quality management guarantee state-of-the-art instruments and accessories and a leading position with regard to quality, reliability and economy also for the future.



The ECHOGRAPH 1095 is ideally suited for the detection of cavities, inclusions, segregation or lack of fusion in steel, castings, nonferrous metals, ceramics, plastics and further sound conducting materials.



Probes constitute the core of ultrasonic testing. They transmit and receive the ultrasonic signal. Depending on the application, manual, immersion, system or special probes are used. Cutting edge technology and diversity are in demand here.

| | |
|---|----|
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This catalogue gives an overview of the standard probes for manual testing from the KARL DEUTSCH product portfolio, as well as a small selection of probes for ultrasonic testing systems and of special probes. Phased array probes for manual and automated testing can be found in the leaflet "P 14 Phased Array".

We would be pleased to advise you on the selection and suitability of probes, since we have already developed and manufactured a wide range of special probes, precisely tailored and optimized for the requirements of the special field of application.

Feel free to contact us!

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Straight Beam Probes Protective Layer, Type W



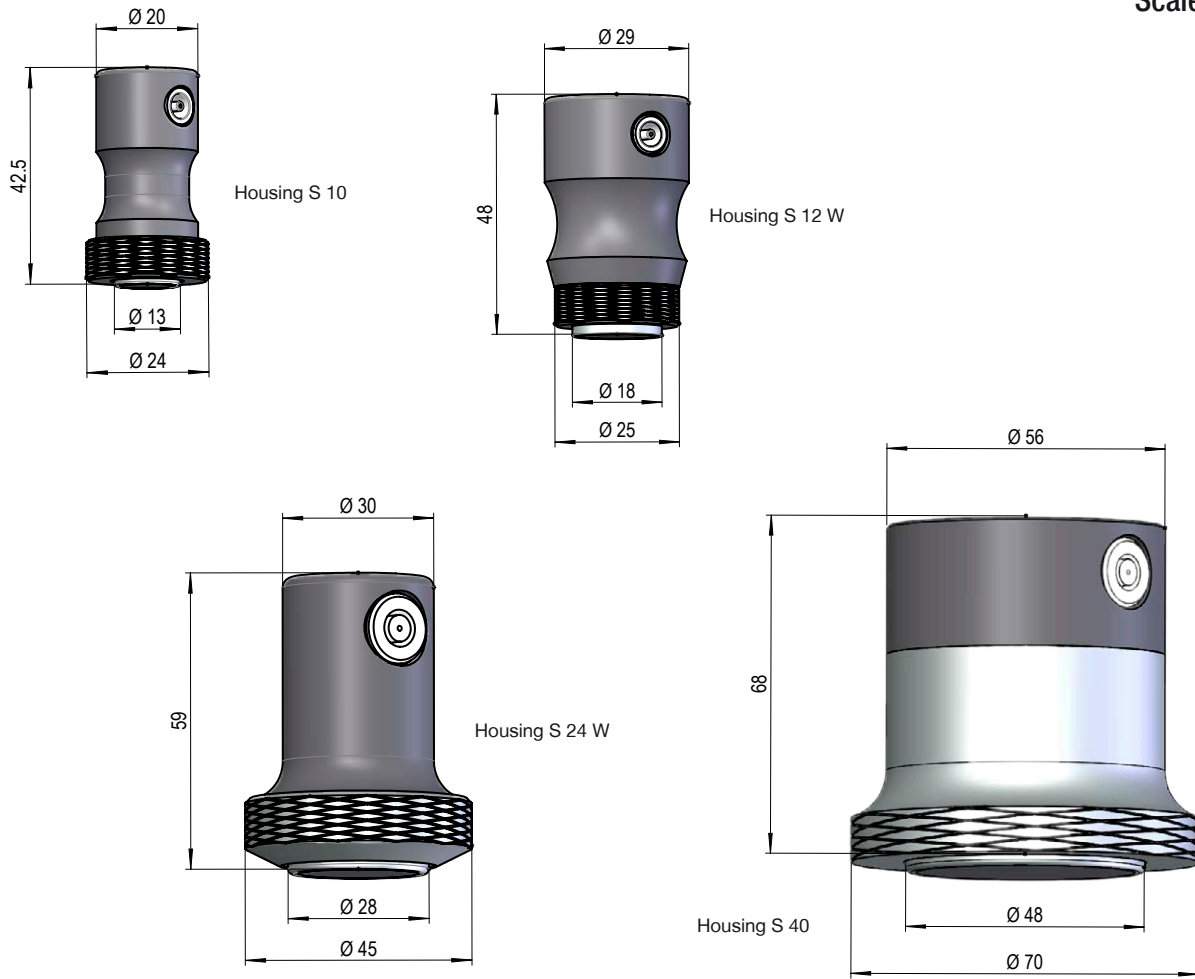
Probes with soft protective layer

Protective layer type W

- suitable for DGS with replaceable protective foil
- small to medium bandwidth
- typical application: inspection of components with rough surface

Straight Beam Probes Protective Layer, Type W

Scale 1 : 1.5



| Frequency [MHz] | Typical bandwidth [%] | Typical test range [mm] | Near field length* [mm] | Part code | Order no. |
|--|-----------------------|-------------------------|-------------------------|------------|-----------|
| Element diameter 10 mm, female connector: Lemo 00, housing S 10 | | | | | |
| 2 | 70 | 50 - 500 | 8.5 | S 10 W 2 C | 1410.004 |
| 4 | 70 | 25 - 800 | 14 | S 10 W 4 C | 1410.003 |
| 6 | 70 | 15 - 1500 | 23 | S 10 W 6 C | 1410.002 |
| Element diameter 12 mm, female connector: Lemo 00, housing S 12 W | | | | | |
| 1 | 50 | 50 - 500 | 6 | S 12 W 1 | 1401.005 |
| 2 | 50 | 25 - 1000 | 12 | S 12 W 2 | 1401.004 |
| 4 | 50 | 15 - 2000 | 24 | S 12 W 4 | 1401.003 |
| 6 | 50 | 10 - 2500 | 36 | S 12 W 6 | 1401.002 |
| Element diameter 24 mm, female connector: Lemo 1, housing S 24 W | | | | | |
| 1 | 40 | 70 - 1000 | 23 | S 24 W 1 | 1402.101 |
| 2 | 40 | 25 - 2000 | 46 | S 24 W 2 | 1402.201 |
| 4 | 40 | 15 - 3000 | 87 | S 24 W 4 | 1402.401 |
| Element diameter 40 mm, female connector: Lemo 1, housing S 40 | | | | | |
| 1 | 40 | 70 - 1000 | 78 | S 40 W 1 | 1408.007 |

* in steel

Straight Beam Probes Protective Layer, Type H/HB

Probes with hard protective layer

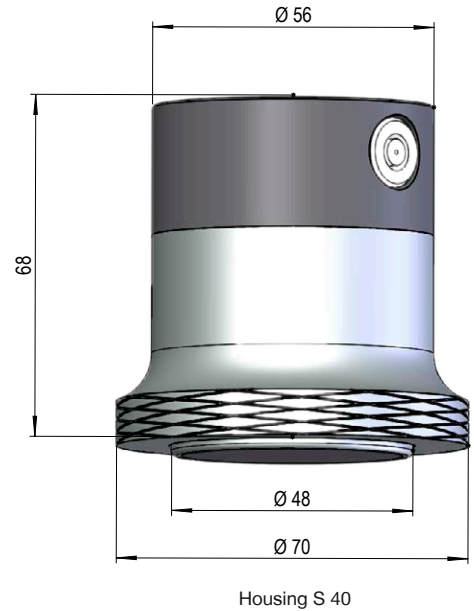
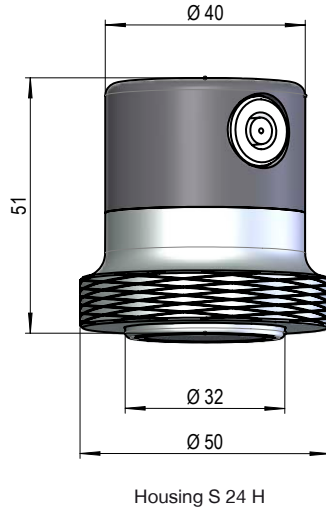
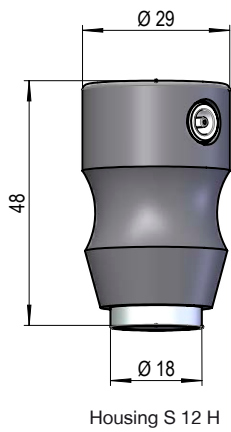
Protective layer type H/HB

- appropriate for DGS
- wear resisting protective layer
- small to medium bandwidth
- typical application: inspection of components with even surface



Straight Beam Probes Protective Layer, Type H/HB

Scale 1 : 1.5



| Frequency [MHz] | Typical bandwidth [%] | Typical test range [mm] | Near field length* [mm] | Part code | Order no. |
|--|-----------------------|-------------------------|-------------------------|-------------|-----------|
| Element diameter 12 mm, female connector: Lemo 00, housing S 12 H | | | | | |
| 1 | 70 | 30 - 1500 | 6.5 | S 12 HB 1 | 1411.009 |
| 2 | 40 | 25 - 3000 | 14 | S 12 H 2 | 1411.006 |
| 2 | 70 | 15 - 3000 | 14 | S 12 HB 2 | 1411.008 |
| 4 | 40 | 15 - 5000 | 27 | S 12 H 4 | 1411.005 |
| 4 | 70 | 8 - 5000 | 27 | S 12 HB 4 | 1411.003 |
| 6 | 40 | 10 - 7500 | 40 | S 12 H 6 | 1411.004 |
| 6 | 70 | 5 - 7500 | 40 | S 12 HB 6 | 1411.002 |
| Element diameter 24 mm, female connector: Lemo 1, housing S 24 H | | | | | |
| 0.5 | 70 | 100 - 500 | 14 | S 24 HB 0,5 | 1412.013 |
| 1 | 40 | 70 - 1000 | 27 | S 24 H 1 | 1412.007 |
| 1 | 70 | 70 - 1000 | 27 | S 24 HB 1 | 1412.009 |
| 2 | 40 | 25 - 2000 | 52 | S 24 H 2 | 1412.006 |
| 2 | 70 | 25 - 2000 | 52 | S 24 HB 2 | 1412.008 |
| 4 | 40 | 15 - 3000 | 100 | S 24 H 4 | 1412.005 |
| 4 | 70 | 15 - 3000 | 100 | S 24 HB 4 | 1412.003 |
| Element diameter 40 mm, female connector: Lemo 1, housing S 40 | | | | | |
| 0.5 | 60 | 100 - 500 | 36 | S 40 HB 0,5 | 1408.005 |
| 1 | 60 | 50 - 1000 | 62 | S 40 HB 1 | 1408.006 |

* in steel

Straight Beam Probes Heavily Damped Probes

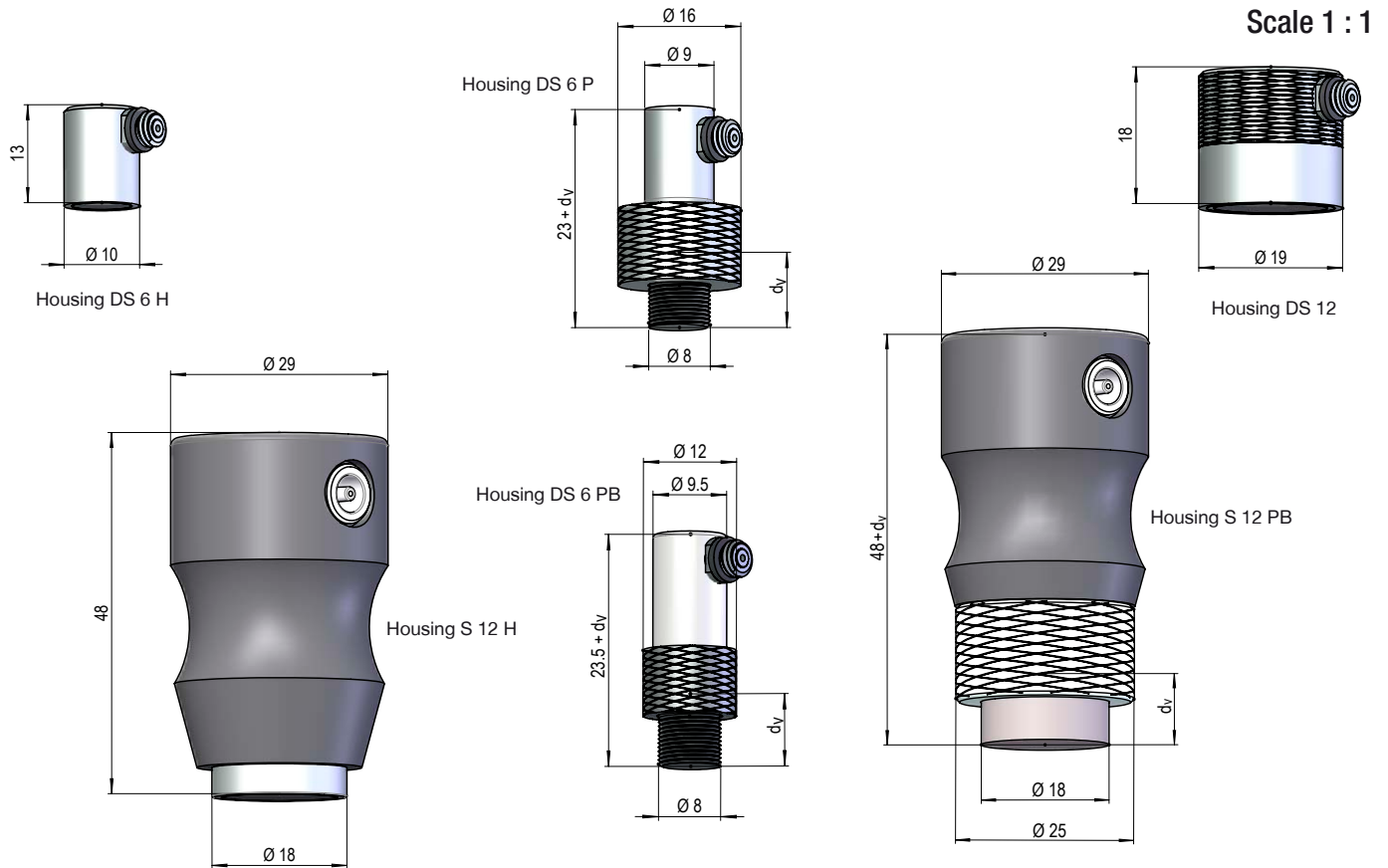


Heavily damped probes

Wear resisting protective layer or exchangeable delay line

- extreme bandwidth, short pulse shape
- typical application:
thickness measurement,
inspection of sound scattering materials
- standard or fingertip design

Straight Beam Probes Heavily Damped Probes

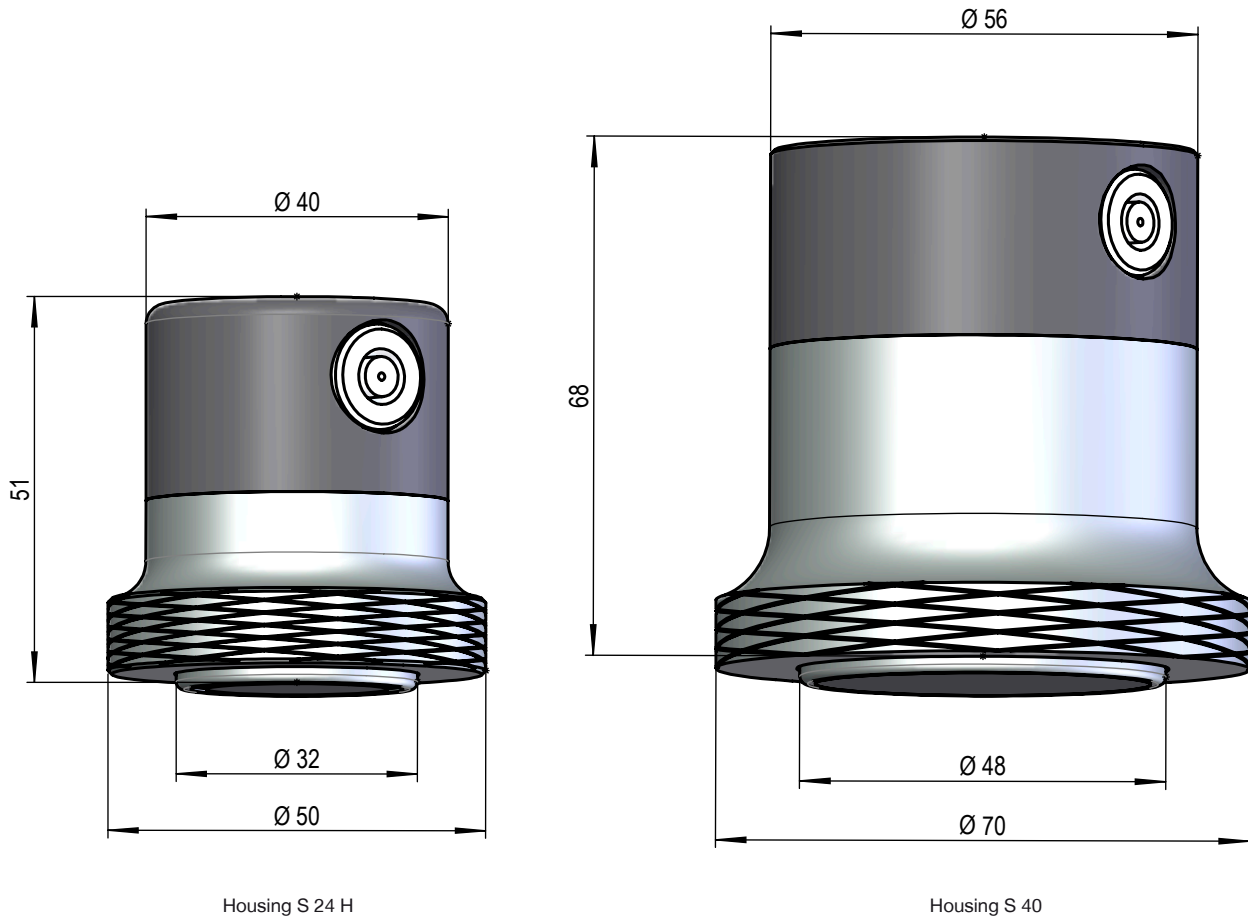


| Frequency range [MHz] | Typical test range [mm] | Housing | Part code | Order no. | Note* |
|---|---|---------|----------------|-----------|--|
| Element diameter 6 mm, typical bandwidth 100 %, female connector: Microdot | | | | | |
| 2 - 7 | (TP-BE): from 1.5 (BE-BE): from 1.5 | DS 6 H | DS 6 HB 2-7 | 1432.702 | - |
| 4 - 12 | (TP-BE): from 1.0 (BE-BE): from 1.0 | DS 6 H | DS 6 HB 4-12 | 1432.701 | - |
| 4 - 14 | (TP-BE): 1.0 to 2·d _v (BE-BE): 0.25 to d _v | DS 6 P | DS 6 PB 4-14 | 1422.001 | exchangeable delay line (d _v = 10 mm) |
| 4 - 14 | (TP-BE): 1.0 to 2·d _v (BE-BE): 0.25 to d _v | DS 6 PB | DS 6 PB 4-14 | 1422.701 | exchangeable delay line (d _v = 10 mm) |
| Element diameter 12 mm, typical bandwidth 100 %, female connector: Lemo 00 (except housing type DS 12) | | | | | |
| 0.8 - 3 | (TP-BE): from 2.0 (BE-BE): from 4.0 | S 12 H | S 12 HB 0,8-3 | 1411.010 | - |
| 0.8 - 3 | (TP-BE): from 2.0 (BE-BE): from 4.0 | DS 12 | DS 12 HB 0,8-3 | 1433.703 | female connector: Microdot |
| 1 - 3 | (TP-BE): 2.0 to 2·d _v (BE-BE): 2.0 to d _v | S 12 PB | S 12 PB 1-3 | 1422.004 | exchangeable delay line (d _v = 10/25 mm) |
| 1 - 7 | (TP-BE): 1.5 to 2·d _v (BE-BE): 1.0 to d _v | S 12 PB | S 12 PB 1-7 | 1422.703 | exchangeable delay line (d _v = 10/25 mm) |
| 1 - 8 | (TP-BE): from 2.0 (BE-BE): from 2.0 | S 12 H | S 12 HB 1-8 | 1411.001 | |
| 2 - 7 | (TP-BE): from 2.0 (BE-BE): from 2.0 | DS 12 | DS 12 HB 2-7 | 1433.705 | female connector: Microdot |

* more delay lines to be found in section "Accessories"

Straight Beam Probes Heavily Damped Probes

Scale 1 : 1



| Frequency range [MHz] | Typical test range [mm] | Housing | Part code | Order no. |
|--|--|---------|-----------------|-----------|
| Element diameter 24 mm, typical bandwidth 100 %, female connector: Lemo 1 | | | | |
| 0.2 - 0.6 | (TP-BE): from 8.0 (BE-BE): from 8.0 | S 24 H | S 24 HB 0,2-0,6 | 1412.016 |
| 0.3 - 1.3 | (TP-BE): from 4.0 (BE-BE): from 5.0 | S 24 H | S 24 HB 0,3-1,3 | 1412.012 |
| 0.4 - 2 | (TP-BE): from 3.0 (BE-BE): from 3.0 | S 24 H | S 24 HB 0,4-2 | 1412.011 |
| 0.5 - 4 | (TP-BE): from 2.0 (BE-BE): from 2.0 | S 24 H | S 24 HB 0,5-4 | 1412.010 |
| Element diameter 40 mm, typical bandwidth 100 %, female connector: Lemo 1 | | | | |
| 0.1 - 0.3 | (TP-BE): from 15.0 | S 40 | S 40 HB 0,1-0,3 | 1408.003 |
| 0.2 - 0.6 | (TP-BE): from 8.0 (BE-BE): from 9.0 | S 40 | S 40 HB 0,2-0,6 | 1408.002 |
| 0.3 - 1 | (TP-BE): from 6.0 (BE-BE): from 6.0 | S 40 | S 40 HB 0,3-1 | 1408.001 |

Straight Beam Probes TR Probes

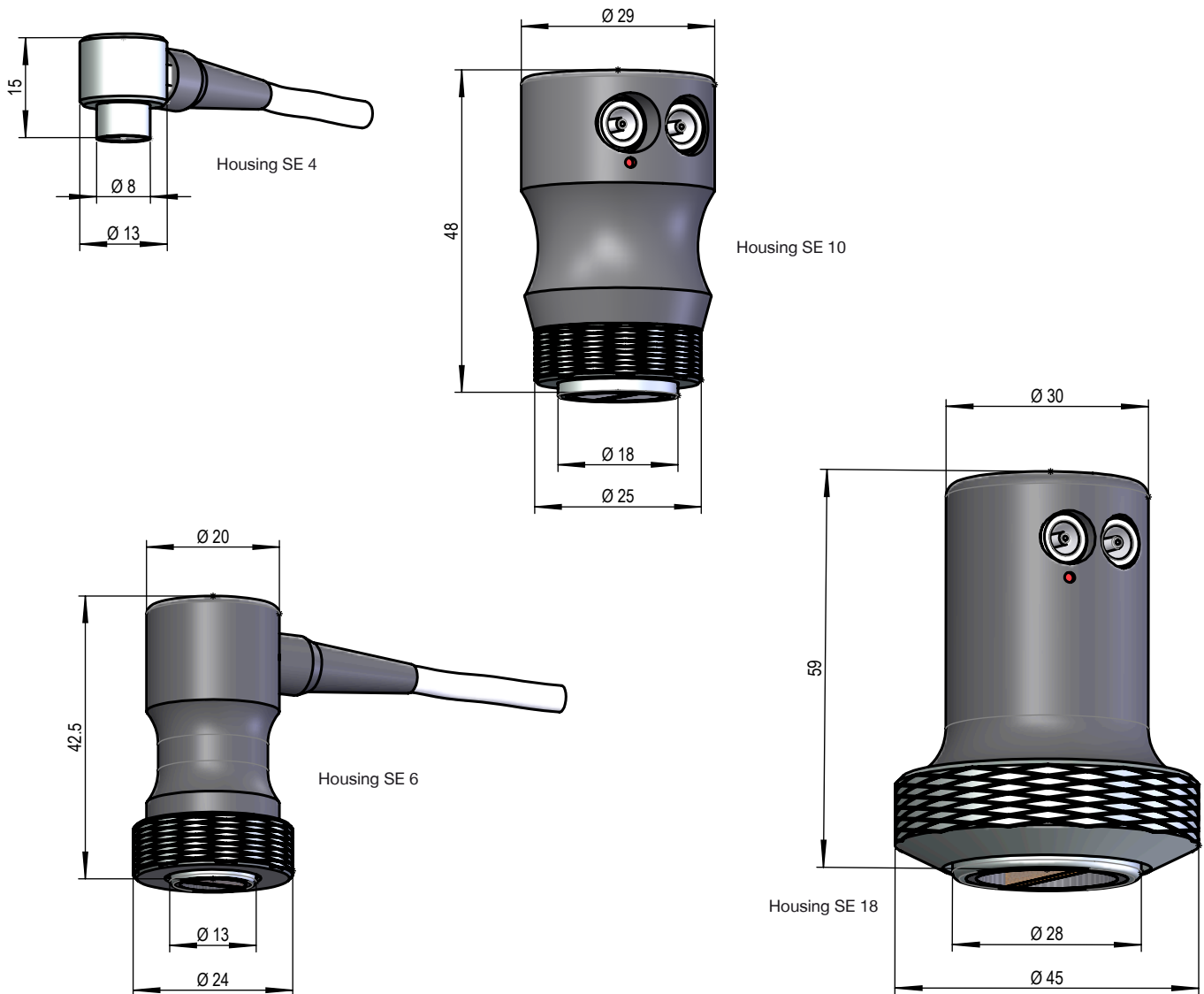
TR probes

- increased near surface resolution
- maximum sensitivity at focus distance
- reduced scattering echoes
- typical application: near surface flaw detection, determination of residual wall thickness



Straight Beam Probes TR Probes

Scale 1 : 1



| Focus distance* [mm] | Element dimensions [mm] | Frequency [MHz] | Housing | Part code | Order no. | Note |
|----------------------|-------------------------|-----------------|---------|-----------------|-----------|------------------------|
| 4 | 4 x 2 | 6 | SE 4 | SE 4.2/4 P 6 | 1464.001 | 1.5 m cable, 2x Lemo 1 |
| 4 | 4 x 2 | 10 | SE 4 | SE 4.2/4 PB 10 | 1464.101 | 1.5 m cable, 2x Lemo 1 |
| 5 | Ø 6 | 4 | SE 6 | SE 6/5 PB 4 C | 1464.165 | 1.5 m cable, 2x Lemo 1 |
| 6 | Ø 10 | 4 | SE 10 | SE 10/6 PB 4 C | 1462.106 | 2x Lemo 00 socket |
| 6 | Ø 10 | 6 | SE 10 | SE 10/6 PB 6 C | 1462.206 | 2x Lemo 00 socket |
| 10 | Ø 10 | 2 | SE 10 | SE 10/10 PB 2 C | 1462.044 | 2x Lemo 00 socket |
| 14 | Ø 10 | 4 | SE 10 | SE 10/14 PB 4 C | 1462.144 | 2x Lemo 00 socket |
| 25 | Ø 18 | 2 | SE 18 | SE 18/25 PB 2 | 1463.225 | 2x Lemo 00 socket |
| 25 | Ø 18 | 4 | SE 18 | SE 18/25 PB 4 | 1463.425 | 2x Lemo 00 socket |
| 40 | Ø 18 | 4 | SE 18 | SE 18/40 PB 4 | 1463.440 | 2x Lemo 00 socket |

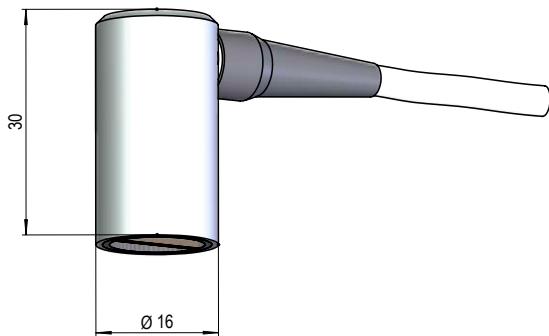
* in steel

Straight Beam Probes

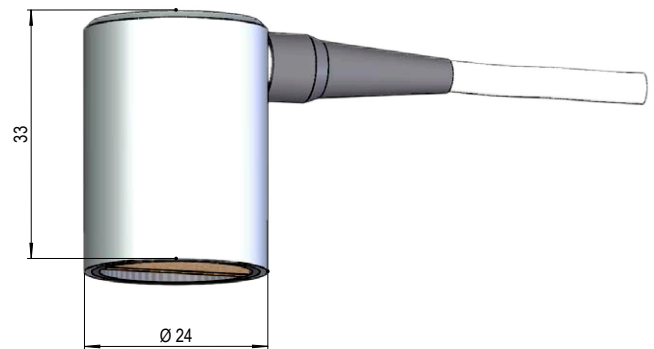
TR Probes for Wall Thickness Gauges ECHOMETER 1076/1077



Scale 1 : 1



Housing DSE 10



Housing DSE 18

| Focus distance* [mm] | Element dimensions [mm] | Frequency [MHz] | Housing | Part code | Order no. | Note |
|----------------------|-------------------------|-----------------|---------|--------------------|-----------|--|
| 4 | 4 x 2 | 10 | SE 4 | DSE 4.2/4 PB 10 | 1465.671 | 1 m cable, 2x Lemo 00 |
| 6 | 10 x 4 | 4 | DSE 10 | DSE 10.4/6 PB 4 | 1465.762 | 1 m cable, 2x Lemo 00 |
| 15 | 8 x 3 | 5 | DSE 10 | DSE 8.3/15 PB 5 C | 1465.771 | 1 m cable, 2x Lemo 00, only for 1076 TC and 1077 |
| 15 | 8 x 3 | 5 | DSE 10 | DSE 8.3/15 PB 5 HT | 1465.772 | 1 m cable, 2x Lemo 00, only for 1076 TC and 1077, operating range up to 150 °C |
| 25 | Ø 18 | 2 | DSE 18 | DSE 18/25 PB 2 | 1465.361 | 1 m cable, 2x Lemo 00 |

* in steel

Angle Beam Probes Transversal Waves

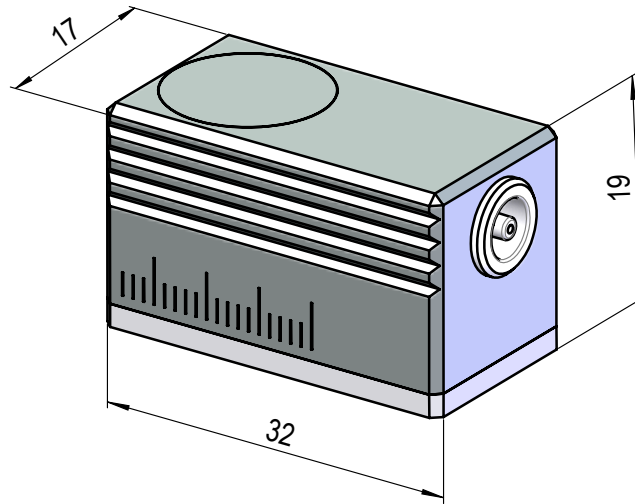


Angle beam probes

- appropriate for DGS
- Typical application: testing of welds, forgings, castings, etc.

Angle Beam Probes Transversal Waves

Scale 2 : 1



Housing WK

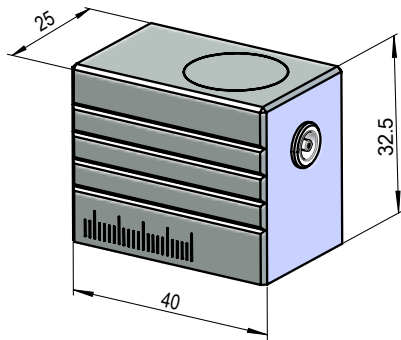
| Beam angle* [°] | Frequency [MHz] | Part code | Order no. |
|--|--------------------|--------------|-----------|
| small size design: element 9 mm by 8 mm, female connector: Lemo 00 (alternative: output on top), housing: WK | | | |
| 35 | 2 | WK 35 PB 2 | 1441.001 |
| 35 | 2 | WK 35 PB 2C | 1441.101 |
| 35 | 4 | WK 35 PB 4 | 1441.011 |
| 45 | 2 | WK 45 PB 2 | 1441.002 |
| 45 | 2 | WK 45 PB 2 C | 1441.102 |
| 45 | 4 | WK 45 PB 4 | 1441.012 |
| 60 | 2 | WK 60 PB 2 | 1441.003 |
| 60 | 2 | WK 60 PB 2 C | 1441.103 |
| 60 | 4 | WK 60 PB 4 | 1441.013 |
| 70 | 2 | WK 70 PB 2 | 1441.004 |
| 70 | 2 | WK 70 PB 2 C | 1441.104 |
| 70 | 4 | WK 70 PB 4 | 1441.014 |
| 80 | 2 | WK 80 PB 2 | 1441.005 |
| 80 | 4 | WK 80 PB 4 | 1441.015 |
| 90 | 2 | WK 90 PB 2 | 1441.006 |
| 90 | 4 | WK 90 PB 4 | 1441.016 |

* beam angle of transversal wave in steel

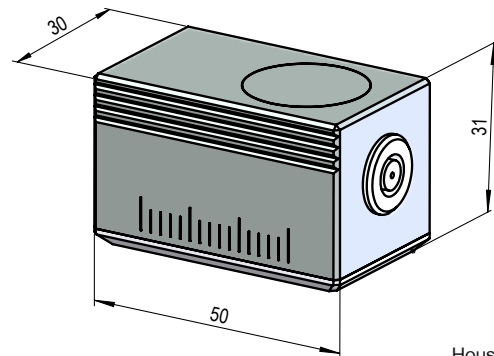
Angle Beam Probes Transversal Waves

| Beam angle* [°] | Frequency [MHz] | Part code | Order no. |
|--|--------------------|---------------|-----------|
| medium size design: element 14 mm by 14 mm, female connector: Lemo 00 (alternative: output on top), housing: SWM | | | |
| 35 | 2 | SWM 35 PB 2 C | 1498.181 |
| 45 | 2 | SWM 45 PB 2 C | 1498.081 |
| 45 | 5 | SWM 45 PB 5 C | 1498.125 |
| 60 | 2 | SWM 60 PB 2 C | 1498.116 |
| 60 | 5 | SWM 60 PB 5 C | 1498.126 |
| 70 | 2 | SWM 70 PB 2 C | 1498.117 |
| 70 | 5 | SWM 70 PB 5 C | 1498.127 |

Scale 1 : 1.5



Housing SWM



Housing WG

| Beam angle* [°] | Frequency [MHz] | Part code | Order no. |
|--|--------------------|--------------|-----------|
| large size design: element 24 mm by 16 mm, female connector: Lemo 1, housing: WG | | | |
| 35 | 1 | WG 35 PB 1 C | 1416.135 |
| 35 | 2 | WG 35 PB 2 | 1416.235 |
| 35 | 4 | WG 35 PB 4 | 1416.435 |
| 45 | 1 | WG 45 PB 1 C | 1416.145 |
| 45 | 2 | WG 45 PB 2 | 1416.245 |
| 45 | 4 | WG 45 PB 4 | 1416.445 |
| 60 | 1 | WG 60 PB 1 C | 1416.160 |
| 60 | 2 | WG 60 PB 2 | 1416.260 |
| 60 | 4 | WG 60 PB 4 | 1416.460 |
| 70 | 1 | WG 70 PB 1 C | 1416.170 |
| 70 | 2 | WG 70 PB 2 | 1416.270 |
| 70 | 4 | WG 70 PB 4 | 1416.470 |

* beam angle of transversal wave in steel

Angle Beam Probes with Wedges

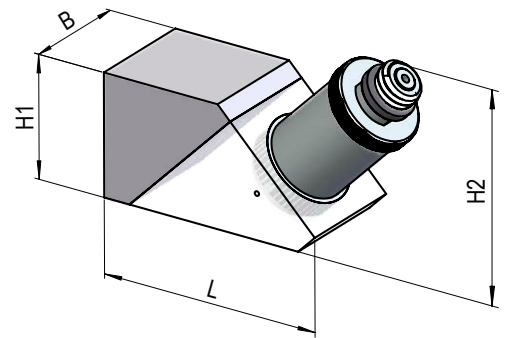


Example: S 6 WB 5 WM with angle beam wedge WM 60

| Frequency [MHz] | Part code | Order no. |
|---|----------------|-----------|
| Element diameter 6 mm, Female connector: Microdot, housing: S 6 | | |
| 2.25 | S 6 WB 2.25 WM | 1457.001 |
| 5 | S 6 WB 5 WM | 1457.002 |
| 10 | S 6 WB 10 WM | 1457.003 |

| Angle beam wedges WM | | | |
|----------------------|-----------|-----------|----------------------------|
| Beam angle* [°] | Part code | Order no. | Dimensions L / B / H1 / H2 |
| 45 | WM 45 | 1818.001 | 21 / 12.5 / 11 / 19 |
| 60 | WM 60 | 1818.002 | 25 / 12.5 / 13.5 / 20 |
| 70 | WM 70 | 1818.003 | 26.5 / 12.5 / 13.5 / 21 |
| 90** | WM 90 | 1818.004 | 25 / 12.5 / 15 / 17 |

** surface wave



Housing S 6 with wedge

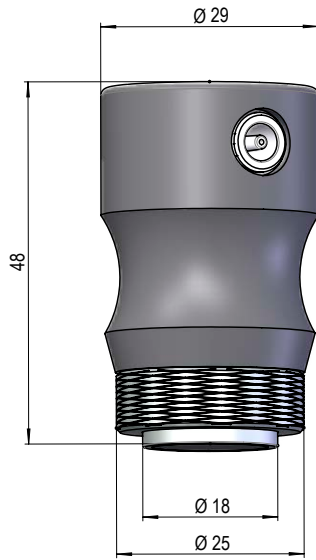


* beam angle of transversal wave in steel

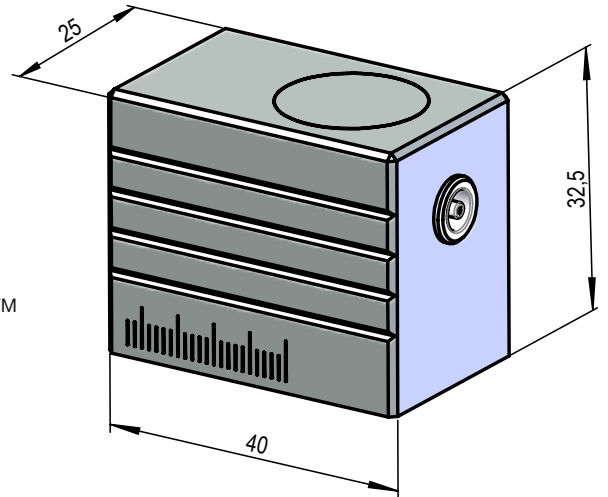
Angle Beam Probes Longitudinal Waves

Scale 1 : 1

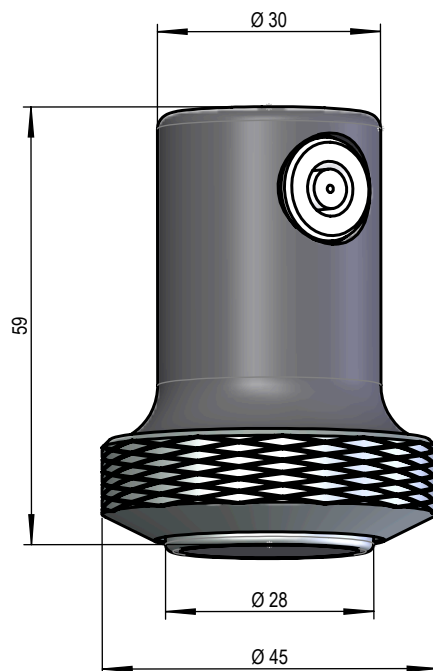
Housing S 12 W



Housing SWM



Housing S 24 W



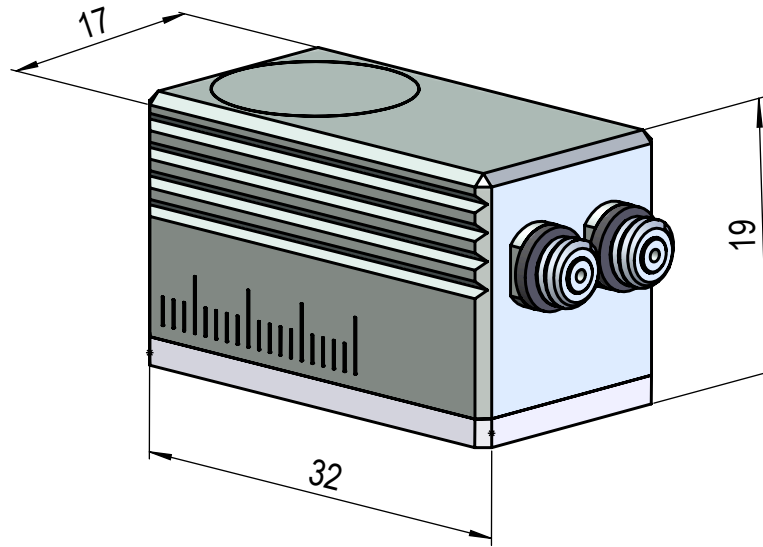
Angle Beam Probes Longitudinal Waves

| Beam angle* [°] | Frequency [MHz] | Part code | Order no. |
|---|--------------------|------------------|-----------|
| Element diameter 10 mm, female connector: Lemo 00, housing: S 12 W | | | |
| 7 | 2 | SWL 10/7 P 2 | 1498.248 |
| 7 | 4 | SWL 10/7 P 4 | 1498.155 |
| 14 | 2 | SWL 10/14 P 2 | 1498.249 |
| 14 | 4 | SWL 10/14 P 4 | 1498.156 |
| 21 | 2 | SWL 10/21 P 2 | 1498.250 |
| 21 | 4 | SWL 10/21 P 4 | 1498.157 |
| 28 | 2 | SWL 10/28 P 2 | 1498.251 |
| 28 | 4 | SWL 10/28 P 4 | 1498.158 |
| Element diameter 12 mm, female connector: Lemo 00, housing: SWM | | | |
| 45 | 2 | SWL 12/45 PB 2 C | 1498.135 |
| 45 | 4 | WL 12/45 PB 4 C | 1456.001 |
| 60 | 2 | SWL 12/60 PB 2 C | 1498.136 |
| 60 | 4 | WL 12/60 PB 4 C | 1456.002 |
| 70 | 2 | SWL 12/70 PB 2 C | 1498.137 |
| 70 | 4 | WL 12/70 PB 4 C | 1456.003 |
| Element diameter 24 mm, female connector: Lemo 1, housing: S 24 W | | | |
| 7 | 2 | SWL 24/7 P 2 | 1498.100 |
| 7 | 4 | SWL 24/7 P 4 | 1498.148 |
| 14 | 2 | SWL 24/14 P 2 | 1498.101 |
| 14 | 4 | SWL 24/14 P 4 | 1498.149 |
| 21 | 2 | SWL 24/21 P 2 | 1498.102 |
| 21 | 4 | SWL 24/21 P 4 | 1498.150 |
| 28 | 2 | SWL 24/28 P 2 | 1498.103 |
| 28 | 4 | SWL 24/28 P 4 | 1498.151 |

* beam angle of longitudinal wave in steel

Angle Beam Probes Angle Beam TR Probes

Scale 1.5 : 1



Housing SE-WK

| Beam angle* [°] | Element- dimensions [mm] | Part code | Order no. |
|---|-----------------------------|------------------|-----------|
| Transversal waves, frequency: $f = 4$ MHz (2 MHz on request), female connector: Microdot, housing: SE-WK | | | |
| 45 | 5 x 6 | WSE 5.6/45 PB 4 | 1461.311 |
| 60 | 5 x 6 | WSE 5.6/60 PB 4 | 1461.312 |
| 70 | 5 x 6 | WSE 5.6/70 PB 4 | 1461.313 |
| Longitudinal waves, frequency: $f = 4$ MHz (2 MHz on request), female connector: Microdot, housing: SE-WK | | | |
| 45 | 5 x 8 | WSEL 5.8/45 PB 4 | 1461.401 |
| 60 | 5 x 8 | WSEL 5.8/60 PB 4 | 1461.402 |
| 70 | 5 x 8 | WSEL 5.8/70 PB 4 | 1461.403 |

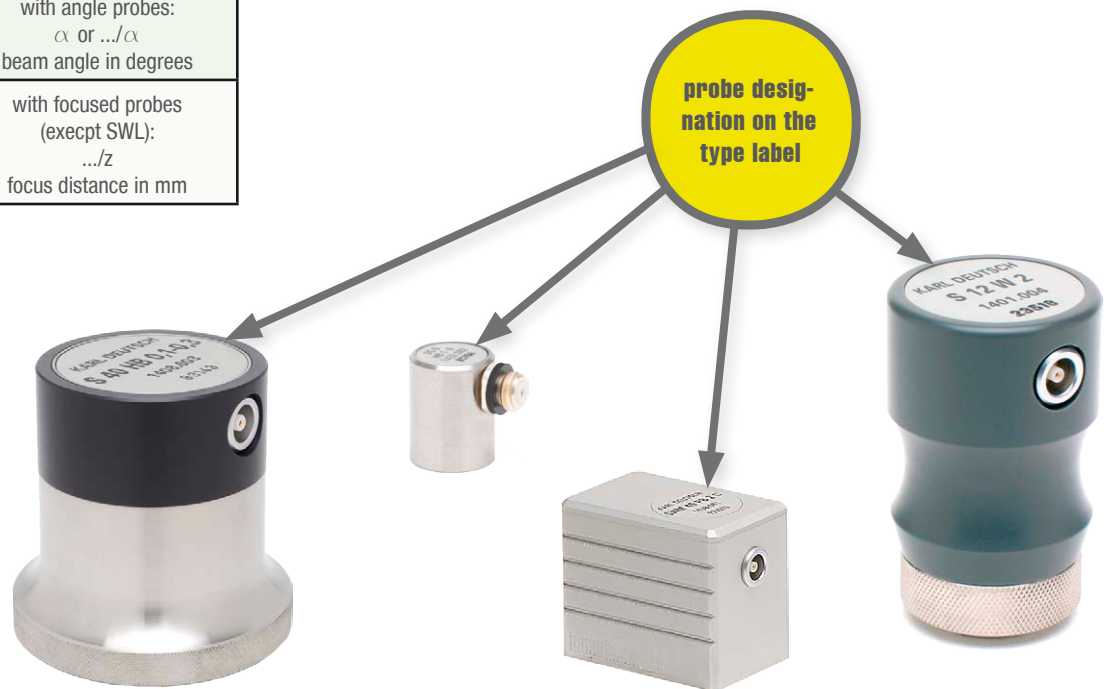
* in steel

Probes

Technical Meaning of the Part Code

ECHOGRAPH probes can be identified by their order number or part code. The technical meaning of the alphanumeric part code is described below:

| Type | Element Dimensions | Specifications | Nominal Frequency | Additional Information |
|--|---|---|--|---|
| S = straight beam probe (DS = fingertip design) | with round elements: n or n/... element diameter in mm | H = hard wear plate W = protective foil P = plastics delay line B = extended or extreme band- width (with frequency limits) | Frequency in MHz, frequency limits are given as upper and lower cut-off frequency (-6 dB) | C = composite element WM = for angle beam wedges HT = for high temperatures |
| SE = TR-probe (transmitter/ receiver) (DSE = fingertip design) | with rectangular elements: l.b or l.b/... element dimensions with length (l) and width (b) in mm | | | |
| WK = angle beam probe (small) SWM = angle beam probe (med) WG = angle beam probe (large) | with angle probes: α or .../ α beam angle in degrees | | | |
| WL and SWL = angle beam probe (longitudinal waves) | with focused probes (except SWL): .../z focus distance in mm | | | |
| WSE = TR angle beam probe | | | | |



Examples

S 10 W 2 C

Straight beam probe, element diameter 10 mm, protective foil, nominal frequency 2 MHz, composite element

DS 12 HB 2-7

Straight beam probe in fingertip design, element diameter 12 mm, hard wear plate, extreme bandwidth 2-7 MHz

SWL 24/21 PB 2

Special angle beam longitudinal wave probe, element diameter 24 mm, beam angle 21°, plastic delay line, extended bandwidth 2 MHz

SWM 60 PB 5 C

Special angle beam probe in medium size housing, beam angle 60°, plastic delay line, extended bandwidth 5 MHz, composite element

SE 4.2/4 PB 10

TR probe, element length 4 mm, element width 2 mm, focal distance 4 mm, plastic delay line, extended bandwidth 10 MHz



Multielement probes



Phased Arrays



Phased array probes for manual and automated testing (more information to be found in leaflet "P 14 Phased Array")

Probes

Guidelines for the Choice of Ultrasonic Probes

What has to be considered when selecting ultrasonic probes?

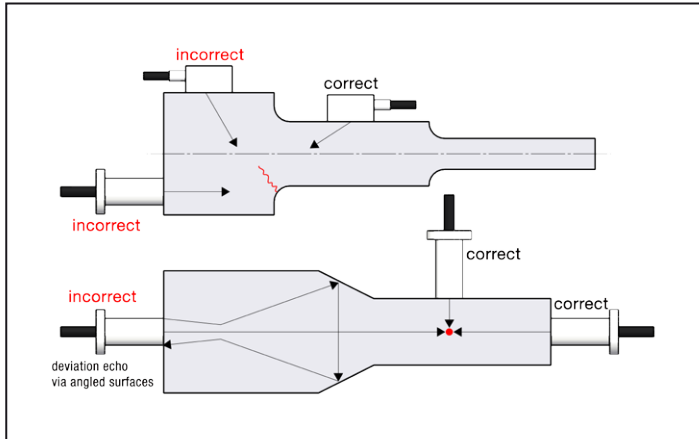
The great variety of ultrasonic probes for NDT applications may initially appear confusing. However, the following notes will facilitate the selection. It is recommended to proceed in the order shown below.

1. Probe type (straight beam or angle beam; single element or dual element)
2. Nominal frequency and bandwidth
3. Element dimensions
4. Wear plate, protective foil or delay line

1. Probe type

Straight beam or angle beam?

- **Select the direction of sound propagation** so the flaws are hit perpendicularly in order to obtain large echo indications, if possible.
- **Use control echos** (for example back-wall echos) from the end of the test area to monitor the coupling of the probe and the occurrence of sound-absorbing or scattering points in the material. This increases the test reliability.
- **Avoid any geometric echos** caused by sound deflections at hidden, round or oblique edges in the material under test.



Example for correct and incorrect direction of insonification

When using TR probes it should be noted that ...

- flaws can not be detected too close to the surface. They have to be outside the “dead zone” which extends from a depth of 0 to approx. 1-3 mm below the surface depending on the type of the TR probe
- the improvement in the near surface resolution (defect detection close to the surface) comes with a lower sensitivity at greater depths
- depending on the surface roughness and curvature of the material under test, an overcoupling echo may occur, which will make the evaluation more difficult
- TR probes should be selected in such a way that the position of the flaws to be detected coincides, as far as possible, with its depth of focus (point of highest sensitivity).

Single or dual element?

Ultrasonic **single element** probes fulfill most of the test tasks in practice. Furthermore they are required in through-transmission mode or when (in rare cases) tandem or delta technique is applied.

Dual element or TR probes (one transmitter and one receiver) are recommended when surface near resolution (for example, detection of small defects in small depth) has to be improved and/or the sensitivity has to be “focused” to a certain depth.

Probes

Guidelines for the Choice of Ultrasonic Probes

2. Nominal frequency and bandwidth

Frequency spectrum and pulse shape of an ultrasonic impulse are linked:

Impulses with **short pulse duration** have a high bandwidth in the frequency spectrum, which means they simultaneously emit a multitude of different frequencies. The superposition results in a short pulse length with regularly only one half cycle.

Impulses with a **longer pulse duration** show several oscillation cycles. They have a pronounced characteristic frequency and a narrow frequency spectrum.

Shortcuts used in the text:

| | |
|-------------|------------------------------|
| λ | = wavelength |
| c | = sound velocity |
| f | = frequency |
| t | = pulse duration |
| ϑ | = opening angle |
| D_{eff} | = effective element diameter |

Indications for high frequency transducers:

- With increasing frequency the wavelength decreases since

$$\lambda = \frac{c}{f}$$

Therefore, the minimum size of detectable reflectors is reduced.

- Due to the relation

$$t = \frac{1}{f}$$

the duration of one or several oscillation cycles decreases in length for higher frequencies. A higher frequency results in a better near surface resolution and an improved axial resolution of reflectors, which lie closely behind each other.

Indications for low frequency transducers are

- highly scattering materials (for example austenitic materials, cast iron with lamellar graphite, non-ferrous casting, etc.)
- highly absorbing materials, e.g. many plastics
- flat, non-perpendicularly orientated flaws. Such reflectors show the same characteristics as an equally-sized transmitter at that position. Since

$$\sin \vartheta_{-20 \text{ dB}} = 1.09 \cdot \frac{c}{f \cdot D_{eff}}$$

the beam divergence of the transmitted and reflected beam increases for lower frequencies. Therefore the probability of detection of the flaws is improved.

Rule of thumb:

- High frequencies for short sound paths in materials with low absorption and / or scattering
- Low frequencies for long sound paths in materials with strong absorption and / or scattering

Note:

A material is generally considered to be testable if the echo of a reference reflector (eg. back wall, side drilled hole or similar) is sufficiently clear (6 - 10 dB) above the noise level (structural noise, electronic noise). If there is no back wall echo due to excessive sound attenuation, it is often possible to use the through transmission method (half sound path).

ECHOGRAPH probes are provided in three different frequency bandwidths which can be selected according to the following criteria:

Small bandwidth

Longer impulses: Since a pronounced test frequency is present, all frequency-dependent data of the sound beam (eg. nearfield length, divergence angle, wavelength, etc.) can be specified. These probes are qualified for the DGS method or similar procedures. The test frequency can be regarded as constant, irrespectively of the material. However, because of the longer lasting impulses, certain limitations have to be made regarding the axial resolution.

Extended bandwidth

Narrow impulses: These probes provide a good compromise between the requirements for high resolution and a defined test frequency. While offering improved resolution, no significant frequency shift occurs in materials with low scattering and absorption. Therefore, specifications of frequency dependent data and applications of test methods are still possible.

Extremely large bandwidth

Narrowest impulses: Probes with these characteristics offer an optimum in resolution and signal-to-noise ratio (structural noise). They are employed with great success in testing highly sound scattering materials (e.g. austenite, casting). Another field of application is the generation of very short impulses for precise wall thickness measurement.

Probes

Guidelines for the Choice of Ultrasonic Probes

3. Element Dimensions

In addition to the frequency and bandwidth, the transducer size primarily determines sound beam parameters such as near field length and divergence angle in the far field. For modifications of the transducer dimensions the changes described below should be considered:

Near field

At the end of the near field (= near field length), the highest test sensitivity is observed because of the maximum constriction of the sound beam. The near field length is calculated as:

$$N = \frac{D_{eff}^2 \cdot f}{4 \cdot c}$$

for circular shaped elements and

$$N_{\blacksquare} = k_{\blacksquare} \cdot \frac{a^2 \cdot f}{4 \cdot c}$$

for rectangular shaped elements. The constant k_{\blacksquare} depends on the ratio of the edge lengths a/b . k_{\blacksquare} amounts to 1.37 for $a/b = 1$, for $a/b > 2$ it amounts to 1.

As a result of interferences in the near field region, sound pressure distribution respectively transducer sensitivity vary locally. Thus, lateral reflector detection and quantitative description are only possible from a distance of approx. 0.7-times the near field length.

Far field

With increasing distance from the transducer and lateral shift from the sound beam axis, the test sensitivity steadily decreases. Lateral flaw detection as well as quantitative description are possible. The opening angle of the sound beam with pulse-echo-mode is calculated as follows:

$$\sin \vartheta_{-20 \text{ dB}} = 0.87 \cdot \frac{c}{f \cdot D_{eff}}$$

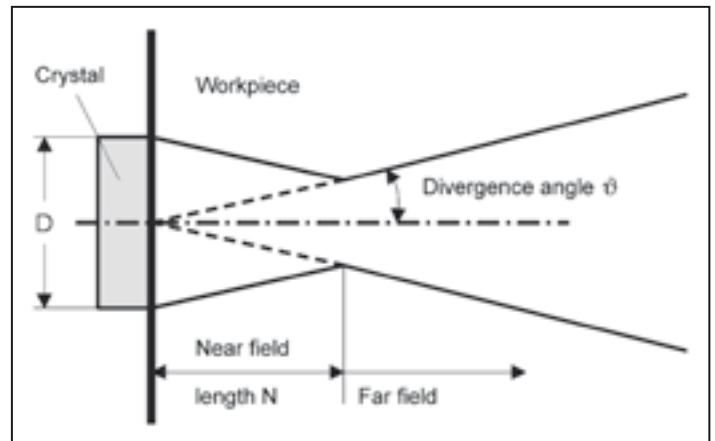
with 20 dB threshold, and

$$\sin \vartheta_{-6 \text{ dB}} = 0.51 \cdot \frac{c}{f \cdot D_{eff}}$$

with 6 dB threshold for circular shaped elements. Divergence angles and near field lengths vary for rectangular shaped elements according to short and long side lengths.

Conclusions

- Small elements provide short near field lengths and large divergence angles in the far field. They should be used therefore in the first place for the detection of flaws at low distances.
- Large transducers have large near field lengths and low opening angles (strong constriction). They are recommended for the detection of reflectors at a greater distance.
- For an optimized detection sensitivity, the element diameter should be chosen in such a way that the near field length coincides approximately with the distance of the flaw.
- If quantitative evaluations (e.g. DGS or reference line) are carried out, the element size has to be chosen considering the near field length is not greater than approx. 1.4 times the distance of the nearest flaw.



Shortcuts used in the text:

- N = near field length
- D_{eff} = effective diameter
(only a few % less than the real element diameter)
- f = frequency
- c = sound velocity
- a = long side of rectangle
- b = short side of rectangle
- ϑ = opening angle

Probes

Guidelines for the Choice of Ultrasonic Probes

4. Wear Plate, Protective Foil or Delay Line

The probe face is equipped with an in general some tenths of a millimeter thick protective layer or a delay line. Apart from protection of the transducer against mechanical damage, they are used for acoustic matching. This comprises a good resolution and an optimum of sound transmission between the involved materials, that are transducer material - protective layer (protective cap, if applicable) - coupling liquid – material under test. The following characteristic features apply:

1. Straight beam probes

Hard protective wear plate made of ceramics or carbide metal, e.g. tungsten carbide or titanium carbide. Extremely wear-resistant, protected with a steel ring. Main applications: For smooth and / or sharp-edged surfaces as well as for broadband probes.

Soft protective foil made of non-slip material for an optimum coupling on rough surfaces. To prohibit excessive wear, the probes never should be used without cap or foil. The generation of very short impulses or broadened frequency spectrum is usually not possible for matching reasons.

Delay Line made of plastics or ceramics: For high-resolution wall thickness measurements or as a heat protection for hot surface measurements. Fixed to the probe housing by using the foil holding ring.

2. Angle beam probes

As wedge material of the angle beam probes in most cases PMMA (e.g. Plexiglas®, Perspex®) is applied, which is a very good compromise between acoustic matching and absorption. In case of wear, a PMMA plate can be glued on the probe face as a wear plate. However, it is recommended to use clamp-on PMMA attachments, which can be customized to all possible surface shapes and are easily exchangeable if worn.

3. TR probes

Solid delay lines made of abrasion resistant plastics such as PMMA or (e.g. for high temperature testing) made of heat-resistant plastics or ceramics material.

Cables

| Part code | Recommended for probe type | Order no. |
|---|----------------------------|-----------|
| Probe cable (1 m), Microdot / Lemo 00 | DS ... / S 6 ... | 1618.010 |
| Probe cable (2 m), Microdot / Lemo 00 | DS ... / S 6 ... | 1618.020 |
| Probe cable (2 m), Microdot / Lemo 1 | DS ... / S 6 ... | 1615.200 |
| Probe cable (1 m), Lemo 00 / Lemo 00 | S 10 ... / S 12 ... | 1616.010 |
| Probe cable (2 m), Lemo 00 / Lemo 00 | S 10 ... / S 12 ... | 1616.020 |
| Probe cable (1 m), Lemo 00 / Lemo 1 | S 10 ... / S 12 ... | 1614.010 |
| Probe cable (2 m), Lemo 00 / Lemo 1 | S 10 ... / S 12 ... | 1614.020 |
| Probe cable (5 m), Lemo 00 / Lemo 1 | S 10 ... / S 12 ... | 1614.050 |
| Probe cable (2 m), Lemo 1 / Lemo 1 | S 24 ... / S 40 ... | 1613.020 |
| Probe cable (5 m), Lemo 1 / Lemo 1 | S 24 ... / S 40 ... | 1613.050 |
| Probe twin cable (2 m), Microdot / Lemo 1 | WSE ... / WSEL ... | 1615.202 |
| Probe twin cable (2 m), Lemo 00 / Lemo 1 | SE 10 ... / SE 18 ... | 1614.022 |
| Probe twin cable (5 m), Lemo 00 / Lemo 1 | SE 10 ... / SE 18 ... | 1614.052 |
| Probe twin cable (1 m), Lemo 00 / Lemo 00 | SE 10 ... / SE 18 ... | 1698.044 |
| Probe twin cable (2 m), Lemo 00 / Lemo 00 | SE 10 ... / SE 18 ... | 1698.077 |




Protective Foils, Retaining Rings, Handling Sleeves

| Part code | Recommended for probe type | Order no. |
|-----------------------------|----------------------------|-----------|
| Pack of 10 protective foils | S 10 W ... | 1930.007 |
| Retaining ring for foils | S 10 W ... | 1931.005 |
| Pack of 10 protective foils | S 12 W ... / SE 10 ... | 1930.006 |
| Retaining ring for foils | S 12 W ... / SE 10 ... | 1931.002 |
| Pack of 10 protective foils | S 24 W ... / SE 18 ... | 1930.008 |
| Retaining ring for foils | S 24 W ... / SE 18 ... | 1931.008 |
| Pack of 10 protective foils | S 40 W ... | 1930.003 |
| Retaining ring for foils | S 40 W ... | 1931.003 |
| Handling sleeves | DSE 4.2 ... / SE 4.2 ... | 1934.251 |
| Pack of 10 protective foils | DSE 4.2 ... / SE 4.2 ... | 1930.005 |
| Handling sleeves | DSE 10.4 ... / DSE 8.3 ... | 1934.151 |
| Pack of 10 protective foils | DSE 10.4 ... / DSE 8.3 ... | 1930.006 |
| Handling sleeves | DSE 18 ... | 1934.201 |
| Pack of 10 protective foils | DSE 18 ... | 1930.004 |

Delay Lines, Replacement Wear Plates, Angle Beam Wedges

| Part code | Recommended for probe type | Order no. |
|--|----------------------------|-----------|
| Delay line (for housing: DS 6 P / DS 6 PB), 10 mm long | DS 6 PB 4-14 | 1932.001 |
| Delay line (for housing: DS 6 P / DS 6 PB), 6 mm | DS 6 PB 4-14 | 1932.003 |
| High temperature delay line (for housing: DS 6 P / DS 6 PB), 10 mm | DS 6 PB 4-14 | 1932.004 |
| Retaining ring (for housing: DS 6 P) | DS 6 PB 4-14 | 1933.001 |
| Retaining ring (for housing: DS 6 PB) | DS 6 PB 4-14 / S 6 WB ... | 1898.011 |
| | | |
| Delay line (for housing: S 12 PB), 10 mm long | S 12 PB ... | 1932.005 |
| Delay line (for housing: S 12 PB), 25 mm long | S 12 PB ... | 1932.006 |
| High temperature delay line (for housing: S 12 PB), 25 mm long | S 12 PB ... | 1932.007 |
| Retaining ring (for housing: S 12 PB) | S 12 PB ... | 1933.010 |
| | | |
| Replacement wear plates (10 pcs) | WK ... | 1935.101 |
| Perspex shoe | WK ... | 1820.171 |
| Clamping spring | WK ... | 1822.170 |
| Replacement wear plates (10 pcs) | SWM ... | 1935.301 |
| Replacement wear plates (10 pcs) | WG ... | 1935.202 |
| Perspex shoe | WG ... | 1819.001 |
| Clamping spring | WG ... | 1821.001 |
| | | |
| Angle beam wedge 45° (screw mountable) | S 6 WB ... | 1818.001 |
| Angle beam wedge 60° (screw mountable) | S 6 WB ... | 1818.002 |
| Angle beam wedge 70° (screw mountable) | S 6 WB ... | 1818.003 |
| Angle beam wedge 90° (screw mountable) | S 6 WB ... | 1818.004 |

Cable Extensions

| Plug type | Required cable coupler | Order no. |
|------------|--|-----------|
| Lemo 1* |  | 1913.001 |
| BNC** |  | 1912.001 |
| Lemo 00*** |  | 1914.001 |






cable required for extension in each case (length shown in parenthesis):

* order no. 1613.020 (2 m) / 1613.050 (5 m)

** order no. 1610.200 (2 m) / 1610.500 (5 m)













*** order no. 1616.010 (1 m) / 1616.020 (2 m)

Adapters














| Connection type | Adapter | Order no. |
|--------------------------------|--|-----------|
| BNC plug <> Lemo 1 socket |  | 1696.001 |
| Lemo 1 plug <> BNC socket |  | 1695.001 |
| Adapter UHF plug <> BNC socket |  | 1697.0011 |
| Lemo 00 plug <> BNC socket |  | 1691.001 |
| BNC plug <> Lemo 00 socket |  | 1698.109 |

Probe Cables for Portables and Systems

Probe Cables for Connection to Portable ECHOGRAPH Instruments

| Probe socket | Plug probe side | Cable length | Order no. | Plug instrument side | Instrument socket |
|--|--|--|--|---|---|
|  |  Microdot | 2 m 2 x 2 m Probe twin cable for TR-probe | 1615.200 1615.202 |  Lemo 1 |  |
|  |  Lemo 00 | 1 m 2 m 5 m 2 x 2 m Probe twin cable for TR probe | 1614.010 1614.020 1614.050 1614.022 | | |
|  |  Lemo 1 | 2 m 5 m | 1613.020 1613.050 | | |
|  |  Lemo 0 hermetic | 2 m | 1611.021 | | |
|  |  Lemo 1 hermetic | 2 m | 1611.022 | | |

Probe Cables for Connection to ECHOGRAPH Test Systems

| Probe socket | Plug probe side | Cable length | Order no. | Plug system electronics | System socket |
|---|---|-------------------|----------------------------------|--|---|
|  |  FVN pressure tight | 2,5 m | 1611.026 |  BNC |  |
|  |  Microdot | 2 m | 1619.020 | | |
|  |  Lemo 00 | 2 m | 1617.020 | | |
|  |  Lemo 1 | 2 m 2 m 5 m | 1612.020 1612.200 1612.500 | | |
|  |  Lemo 0 hermetic | 2 m | 1611.020 | | |
|  |  Lemo 1 hermetic | 2 m | 1611.023 | | |

Company Location Wuppertal and Worldwide Presence



Works 1 at Otto-Hausmann-Ring 101

Management, Administration, Development, Production of Portable Instruments, Sensors and Test Media



Works 2 at Otto-Hausmann-Ring 201

Development, Construction and Production of Ultrasonic, Magnetic Particle and Penetrant Testing Systems

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